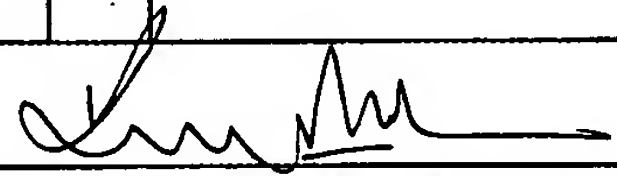


FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. NIP-272	SERIAL NO.	10/092897 16820/01 08/08/02 U.S. PTO	
<b>LIST OF DOCUMENTS CITED BY APPLICANT</b> <i>(Use several sheets if necessary)</i>				APPLICANT H. YAMAZAKI et al			
				FILING DATE March 8, 2002			
				GROUP 2877			
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)	
	AA						
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<b>FOREIGN PATENT DOCUMENTS</b>							
	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
	AL 7-92109	4/7/95	Japan			<input type="checkbox"/>	<input type="checkbox"/>
	AM 8-136476	5/31/96	Japan			<input type="checkbox"/>	<input type="checkbox"/>
	AN					<input type="checkbox"/>	<input type="checkbox"/>
	AO					<input type="checkbox"/>	<input type="checkbox"/>
	AP					<input type="checkbox"/>	<input type="checkbox"/>
<b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
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	AT						
EXAMINER 				DATE CONSIDERED 03 MARCH 2005			

\* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)		APPLICANT H. YAMAZAKI et al	
		FILING DATE March 8, 2002	GROUP 2878 2877

## U.S. PATENT DOCUMENTS

* EXAMINER INITIAL		DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
	AA	5,443,164	08/22/95	Walsh et al			
	AB	4,664,525	05/12/87	Tagaya			
	AC	3,942,897	03/09/76	Takahashi et al			
	AD	5,536,935	07/16/96	Klotzsch et al			
	AE						
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	AL	303175A2	02/15/89	Europe			<input type="checkbox"/>	<input type="checkbox"/>
	AM	WO 90/13810	11/15/90	PCT			<input type="checkbox"/>	<input type="checkbox"/>
	AN						<input type="checkbox"/>	<input type="checkbox"/>
	AO						<input type="checkbox"/>	<input type="checkbox"/>
	AP						<input type="checkbox"/>	<input type="checkbox"/>

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

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10/092,897LIST OF DOCUMENTS CITED BY APPLICANT  
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H. YAMAZAKI et alFILING DATE  
March 8, 2002GROUP  
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## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
<i>DA</i>	AA 5,442,446	08/15/95	Gerber et al			
<i>DA</i>	AB 6,064,479	05/16/00	Knapp			
<i>DA</i>	AC 4,551,627	11/05/85	Reich			
<i>DA</i>	AD 5,523,560	06/04/96	Manique et al			
<i>DA</i>	AE 4,335,960	06/22/82	Ashcroft et al			
<i>DA</i>	AF 4,958,223	09/18/90	Juvinall et al			
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	AH					
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	AJ					
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## FOREIGN PATENT DOCUMENTS

	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
	AL					<input type="checkbox"/>	<input type="checkbox"/>
	AM					<input type="checkbox"/>	<input type="checkbox"/>
	AN					<input type="checkbox"/>	<input type="checkbox"/>
	AO					<input type="checkbox"/>	<input type="checkbox"/>
	AP					<input type="checkbox"/>	<input type="checkbox"/>

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

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H. YAMAZAKI et alFILING DATE  
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## U.S. PATENT DOCUMENTS

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## FOREIGN PATENT DOCUMENTS

	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
AL	07-311160	11/28/95	JP (with English Abstract)			<input type="checkbox"/>	<input type="checkbox"/>
AM	62-011944	1/20/87	JP (with English Abstract)			<input type="checkbox"/>	<input type="checkbox"/>
AN	07-092109	4/07/95	JP (with English Abstract)			<input type="checkbox"/>	<input type="checkbox"/>
AO						<input type="checkbox"/>	<input type="checkbox"/>
AP						<input type="checkbox"/>	<input type="checkbox"/>

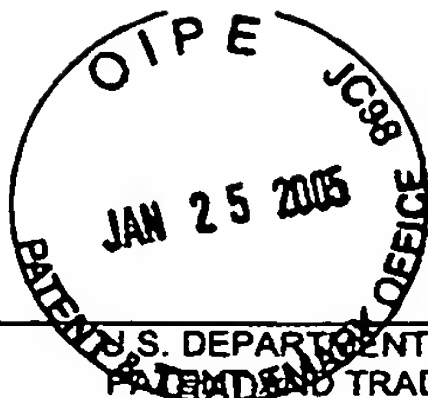
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March 8, 2002GROUP  
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## U.S. PATENT DOCUMENTS

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	AI						
	AJ						
	AK						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	AL	07-092109	04/07/95	JP (with English abstract)			<input type="checkbox"/>	<input type="checkbox"/>
	AM	08-338815	12/24/96	JP (with English abstract)			<input type="checkbox"/>	<input type="checkbox"/>
	AN	01-141342	06/02/89	JP (with English abstract)			<input type="checkbox"/>	<input type="checkbox"/>
	AO	63-282640	11/18/88	JP (with English abstract)			<input type="checkbox"/>	<input type="checkbox"/>
	AP						<input type="checkbox"/>	<input type="checkbox"/>

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